

SLOVENSKI STANDARD oSIST prEN IEC 61987-1:2024

01-marec-2024

Merjenje in nadzor v industrijskih procesih – Strukture podatkov in elementov v katalogih procesne opreme – 1. del: Merilna oprema z analognim in digitalnim izhodom

Industrial-process measurement and control - Data structures and elements in process equipment catalogues - Part 1: Measuring equipment with analogue and digital output

Industrielle Leittechnik - Datenstrukturen und -elemente in Katalogen der Prozessleittechnik - Teil 1: Messeinrichtungen mit analogen und digitalen Ausgängen

Mesure et commande dans les processus industriels - Eléments et structures de données dans les catalogues d'équipements de processus - Partie 1: Equipement de mesure avec sortie analogique et numérique

oSIST prEN IEC 61987-1:2024

https://sTa slovenski standard je istoveten z:0bc-prEN IEC 61987-1:2024 d7/osist-pren-iec-61987-1-2024

ICS:

25.040.40 Merjenje in krmiljenje Industrial process

industrijskih postopkov measurement and control

35.240.50 Uporabniške rešitve IT v IT applications in industry

industriji

oSIST prEN IEC 61987-1:2024 en,fr,de

oSIST prEN IEC 61987-1:2024

iTeh Standards (https://standards.iteh.ai) Document Preview

oSIST prEN IEC 61987-1:2024

https://standards.iteh.ai/catalog/standards/sist/166f00bc-8423-4613-8dec-e8bf3369f8d7/osist-pren-iec-61987-1-2024

oSIST prEN IEC 61987-1:2024

PROJECT NUMBER: IEC 61987-1 ED2

DATE OF CIRCULATION:

2024-01-12



65E/1037/CDV

COMMITTEE DRAFT FOR VOTE (CDV)

CLOSING DATE FOR VOTING:

2024-04-05

	SUPERSEDES DOCUMENTS:				
	65E/1025/CD, 65E/1033/CC				
IEC SC 65E: Devices and integration in ente	ERPRISE SYSTEMS				
SECRETARIAT:		SECRETARY:			
United States of America		Mr Donald (Bob) Lattime	er		
OF INTEREST TO THE FOLLOWING COMMITTEES:		PROPOSED HORIZONTAL STA	ANDARD:		
		Other TC/SCs are requested to indicate their interest, if any, in this CDV to the secretary.			
Functions concerned:					
☐ EMC ☐ ENVIR	ONMENT	Quality assurance	☐ SAFETY		
SUBMITTED FOR CENELEC PARALLEL VOTING		☐ NOT SUBMITTED FOR CE	NELEC PARALLEL VOTING		
Attention IEC-CENELEC parallel voting		andards			
The attention of IEC National Committe CENELEC, is drawn to the fact that this Comm (CDV) is submitted for parallel voting.			.ai)		
The CENELEC members are invited to CENELEC online voting system.	· ·	nt Preview			
tps://standards.iteh.ai/catalog/standards			369f8d7/osist-pren-iec-61987-1-2		
This document is still under study and subject	to change. It should	I not be used for reference	ourposes.		
Recipients of this document are invited to sub aware and to provide supporting documentation		ments, notification of any re	elevant patent rights of which they are		
Recipients of this document are invited to submit, with their comments, notification of any relevant "In Some Countries" clauses to be included should this proposal proceed. Recipients are reminded that the CDV stage is the final stage for submitting ISC clauses. (SEE AC/22/2007 OR NEW GUIDANCE DOC).					
TITLE:					
Industrial-process measurement and co - Part 1: Measuring equipment with ana			process equipment catalogues		
PROPOSED STABILITY DATE: 2026					
NOTE FROM TC/SC OFFICERS:					
Copyright © 2023 International Electrotechnical Commission, IEC. All rights reserved. It is permitted to download this electronic file, to make a copy and to print out the content for the sole purpose of preparing National Committee positions. You may not copy or "mirror" the file or printed version of the document, or any part of it, for any other purpose without permission in writing from IEC.					

- 2 -IEC CDV 61987-1 ED2 2023 CDV ©IEC:2023

1			CONTENTS	
2	4	•	De	4.0
3	1	•		
4	2	Norm		
5	3	Term	ns and definitions	
6		3.1	accuracy (of a measuring instrument), inaccuracy	· 11 -
7		3.2	accuracy class	· 12 -
8		3.3	ambient condition, environmental condition	· 12 -
9		3.4	ambient temperature	· 12 -
10		3.5	ambient temperature limits	· 12 -
11		3.6	ambient temperature range	· 12 -
12		3.7	analog signal	· 12 -
13		3.8	binary signal	· 13 -
14		3.9	climate class	· 13 -
15		3.10	degree of protection	· 13 -
16		3.11	dependability	· 13 -
17		3.12	digital signal	· 13 -
18		3.13	drift	· 13 -
19		3.14	electromagnetic compatibility, EMC	· 13 -
20		3.15	environmental condition class	· 14 -
21		3.16	environmental influence	- 14 -
22		3.17	hysteresis	- 14 -
23		3.18	influence of ambient temperature	· 14 -
24		3.19	influence quantityintegrity	- 14 -
25		3.20	integrity	- 14 -
26		3.21		· 14 -
27		3.22	limiting values for operation	· 15 -
28		3.23	limiting values for storage	· 15 -
29		3.24	limiting values for transport	· 15 -
30		3.25	long-term driftdrift	iec_61987-1-2024
31		3.26	maintainability	· 15 -
32		3.27	measured error	· 15 -
33		3.28	measured variable	· 15 -
34		3.29	measuring range	· 16 -
35		3.30	measuring principle, measurement principle	· 16 -
36		3.31		
37		3.32	nominal range of use	
38			normal operating conditions	
39			operating conditions	
40			operating limits	
41			output variable	
42		3.37	· .	
43		3.38	•	
44			power supply	
45			rangeability	
46		3.41		
47		_	reference operating condition, reference condition	
48			reliability	
49			rise time	
-				-

- 3 -IEC CDV 61987-1 ED2 2023 CDV ©IEC:2023

50		3.45	security	y	- 18 -
51		3.46	settling	time	- 18 -
52		3.47	shock.		- 18 -
53		3.48	signal.		- 19 -
54		3.49	span		- 19 -
55		3.50	standaı	rdized signal	- 19 -
56		3.51	start-up	o drift	- 19 -
57		3.52	storage	e and transportation conditions	19 -
58		3.53	storage	temperature	19 -
59		3.54	therma	response time	- 19 -
60				protection	
61				n	
62				on resistance	
63		3.58		ıp time	
64				ljustment	
65	4			nts	
66	•	4.1		ıl	
67		4.2		ocument chapters and features	
68		4.2	4.2.1	Composite measuring equipment	
			4.2.1		
69		4.0		Measuring equipment with a digital communication interface	
70 71	_	4.3		clature	
71	5			nt for process measuring equipment	
72		5.1		cation	
73			5.1.1	Document identification	23 -
74			5.1.2	Date of issue	23 -
75			5.1.3	Product type	23 -
76			5.1.4	Product name	24 -
77			5.1.5	Version	
78			5.1.6	Manufacturer	
79		5.2		tion/standards/sist/166100bc-8423-4613-8dec-e8bt336918d//osist-pren	
80		5.3		on and system design	
81			5.3.1	Measuring principle	
82			5.3.2	Equipment architecture	
83			5.3.3	Communication and data processing	
84			5.3.4	Dependability	- 24 -
85		5.4	•		
86			5.4.1	Measured variable	- 25 -
87			5.4.2	Measuring range	- 25 -
88		5.5	Output		- 25 -
89			5.5.1	Output signal	- 25 -
90			5.5.2	Signal on alarm	- 26 -
91			5.5.3	Load	- 26 -
92		5.6	Digital	Communication	- 26 -
93			5.6.1	Communication protocol	- 26 -
94			5.6.2	Communication variable	- 26 -
95			5.6.3	Physical layer	- 26 -
96		5.7	Perforn	nance characteristics	- 27 -
97			5.7.1	Accuracy	- 27 -
98			5.7.2	Measured error	- 27 -

- 4 -IEC CDV 61987-1 ED2 2023 CDV ©IEC:2023

99		5.7.3	Hysteresis	27 -
100		5.7.4	Non-repeatability	27 -
101		5.7.5	Start-up drift	27 -
102		5.7.6	Long-term drift	27 -
103		5.7.7	Influence of ambient temperature	27 -
104		5.7.8	Influence of medium temperature	28 -
105		5.7.9	Settling time	28 -
106	5.8	Opera	ting conditions	28 -
107		5.8.1	Installation	28 -
108		5.8.2	Environment	29 -
109		5.8.3	Process	30 -
110	5.9	Mecha	nical and electrical construction	30 -
111		5.9.1	Design	30 -
112		5.9.2	Dimensions	30 -
113		5.9.3	Weight	31 -
114		5.9.4	Material	31 -
115		5.9.5	Electrical connection	31 -
116		5.9.6	Degree of protection	31 -
117		5.9.7	Type of protection	31 -
118		5.9.8	Process connection	31 -
119	5.10	Opera	bility	31 -
120	5.11	Power	Supply	31 -
121	5.12	Certific	cates and approvals	32 -
122	5.13	Orderi	ng Information	32 -
123			nentation	
124	Annex A.			33 -
125	Annex B.		Document Preview	35 -
126	B.1	Additio	onal features proposed for flow measurement principles	35 -
127		B.1.1	Overview OSIST prEN IEC 61987-1:2024	
128		B.1.2	Output ndards/sist/166f00bc-8423-4613-8dec-e8bf3369f8d7/	osist-pren-i386
129		B.1.3	Performance characteristics	
130		B.1.4	Installation	38 -
131		B.1.5	Process	
132		B.1.6	Mechanical construction	39 -
133	B.2	Additio	onal features proposed for level measurement principles	40 -
134		B.2.1	Overview	
135		B.2.2	Input	
136		B.2.3	Output	
137		B.2.4	Performance characteristics	
138		B.2.5	Installation	43 -
139		B.2.6	Process	43 -
140	B.3	Additio	onal features proposed for pressure measurement principles	
141	-	B.3.1	Overview	
142		B.3.2	Function and system design	
143		B.3.3	Input	
144		B.3.4	Output	
145		B.3.5	Performance characteristics	
146		B.3.6	Operating conditions/process	
147		B.3.7	Mechanical and electrical construction	

oSIST prEN IEC 61987-1:2024

- 5 -IEC CDV 61987-1 ED2 2023 CDV ©IEC:2023

148	B.4	Additio	onal features proposed for temperature measurement principles	50 -
149		B.4.1	Overview	50 -
150		B.4.2	Input	53 -
151		B.4.3	Output	53 -
152		B.4.4	Performance characteristics	53 -
153	B.5	Additio	onal features proposed for density measurement principles	54 -
154		B.5.1	Overview	54 -
155		B.5.2	Performance characteristics	57 -
156		B.5.3	Installation conditions	57 -
157		B.5.4	Process conditions	57 -
158 159 160 161				
101				

iTeh Standards (https://standards.iteh.ai) Document Preview

oSIST prEN IEC 61987-1:2024

https://standards.jteh.aj/catalog/standards/sist/166f00bc-8423-4613-8dec-e8bf3369f8d7/osist-pren-jec-61987-1-2024

- 6 -IEC CDV 61987-1 ED2 2023 CDV @IEC:2023

INTERNATIONAL ELECTROTECHNICAL COMMISSION 162 163 164 INDUSTRIAL-PROCESS MEASUREMENT AND CONTROL: 165 DATA STRUCTURES AND ELEMENTS 166 IN PROCESS EQUIPMENT CATALOGUES -167 168 Part 1: Generic structures for measuring equipment 169 170 **FOREWORD** 171 172 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising 173 174 175 all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, 176 177 Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with 178 may participate in this preparatory work. International, governmental and non-governmental organizations liaising 179 with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for 180 Standardization (ISO) in accordance with conditions determined by agreement between the two organizations. 181 182 2) The formal decisions or agreements of IEC on technical matters express, as nearly as possible, an international consensus of opinion on the relevant subjects since each technical committee has representation from all 183 interested IEC National Committees. 184 3) IEC Publications have the form of recommendations for international use and are accepted by IEC National 185 Committees in that sense. While all reasonable efforts are made to ensure that the technical content of IEC 186 Publications is accurate, IEC cannot be held responsible for the way in which they are used or for any 187 misinterpretation by any end user. 188 4) In order to promote international uniformity, IEC National Committees undertake to apply IEC Publications 189 transparently to the maximum extent possible in their national and regional publications. Any divergence between 190 any IEC Publication and the corresponding national or regional publication shall be clearly indicated in the latter. 191 5) IEC provides no marking procedure to indicate its approval and cannot be rendered responsible for any equipment 192 declared to be in conformity with an IEC Publication. 193 6) All users should ensure that they have the latest edition of this publication. 194 7) No liability shall attach to IEC or its directors, employees, servants or agents including individual experts and members of its technical committees and IEC National Committees for any personal injury, property damage or 195 196 other damage of any nature whatsoever, whether direct or indirect, or for costs (including legal fees) and 197 expenses arising out of the publication, use of, or reliance upon, this IEC Publication or any other IEC 198 Publications. 8) Attention is drawn to the Normative references cited in this publication. Use of the referenced publications is 1987-1-2024 199 200 indispensable for the correct application of this publication. 201 9) Attention is drawn to the possibility that some of the elements of this IEC Publication may be the subject of patent 202 rights. IEC shall not be held responsible for identifying any or all such patent rights. 203 International Standard IEC 61987-1 Ed 2. has been prepared by subcommittee 65B65E: 204 Devices and integration in enterprise systems, of IEC technical committee 65: Industrial-205 process measurement and control. 206 The text of this standard is based on the following documents: **FDIS** Report on voting XX/XX/FDIS XX/XX/RVD 207 208 Full information on the voting for the approval of this standard can be found in the report on 209 voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

211 212

- 7 -IEC CDV 61987-1 ED2 2023 CDV ©IEC:2023

213 214 215	The committee has decided that the contents of this publication will remain unchanged until the maintenance result 2028 indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be						
216	• reconfirmed,						
217	 withdrawn, 						
218	 replaced by a revised edition, or 						
219	amended.						
220	A bilingual edition of this standard may be issued at a later date.						
221							
222							

iTeh Standards (https://standards.iteh.ai) Document Preview

oSIST prEN IEC 61987-1:2024

https://standards.iteh.ai/catalog/standards/sist/166f00bc-8423-4613-8dec-e8bf3369f8d7/osist-pren-iec-61987-1-202

- 8 -IEC CDV 61987-1 ED2 2023 CDV ©IEC:2023

INTRODUCTION 223 224 In recent years, industry has become alert to the fact that a great deal of time and effort is 225 wasted in the transposition of measuring equipment data from one form to another. The 226 technical data of an instrument, for example, may exist at the manufacturer's facility as two 227 separate data sets for paper and electronic presentation: the end-user requires much the same 228 data for works standards, engineering data bases or commercial data bases. In most cases, 229 however, the data cannot be automatically re-used because each application has its own 230 particular data storage format. 231 A second problem that belies the re-use of technical data is the content of the product 232 descriptions themselves. There is little agreement between manufacturers on what information a technical data sheet should contain, how it should be arranged, or how the results, for 233 234 example of particular performance tests, should be presented. When transferring this 235 information into a data base, an end-user will always find gaps and proprietary interpretations 236 that make the task more difficult. 237 This part of IEC 61987 aims to solve these problems by defining a generic structure and its 238 content for industrial process measuring and control equipment. It builds upon the assumption 239 that, for a given class of measuring equipment, for example, pressure measuring equipment, 240 temperature measuring equipment or electromagnetic flow-measuring equipment, a set of non-241 proprietary structures and product features can be specified. The resulting documents can not 242 only be exchanged electronically, they can also be presented to humans in an easily 243 understandable form. 244 This part of IEC 61987 is applicable to electronic catalogues of process measuring equipment 245 with analogue and digital output. The structure also contains a great many product features that 246 are common to measuring equipment with binary output. Similarly, Annex B has been prepared 247 with a view to future standardisation. 248 This part of IEC 61987 is not intended as a replacement for existing standards, but rather as a guiding document for all future standards which are concerned with the specifications of process 249 250 measuring equipment. Every revision of an existing standard should take into account the structures and product features defined in Clause 5 of this part of IEC 61987 or work towards 251 252 a harmonisation. 253 Annex A contains a tabular overview of the classification and catalogue structure of process 254 measuring equipment. Annex B contains tables with a further sub-classification for specific 255 measured variables. 256 Wherever possible, existing terms from international standards have been used to name the 257 product features within the structures. In accordance with ISO 10241, Clause 3 of this part of 258 IEC 61987 contains a list of terms, definitions and sources. Documents created according to the standard are structured. A possible means of exchanging 259 structured information free of layout information is given by SGML (Standard Generalised Mark-260 Up Language, ISO 8879) or XML (Extensible Mark-Up Language), which is derived from it. 261 This part of IEC 61987 could also provide the basis for arranging of properties (data element 262 types) that conform to IEC 61360 or ISO 13584. This would require that the features, which in 263 264 this part of IEC 61987 can be textual units, graphical and tabular representations etc., be broken 265 down into properties (data element types) conformant to the said standards. For example, a range would be expressed as a lower range-limit (LRL) and upper range-limit (URL) with unit of 266 267 measure; dimensions (L x B x H) as three separate elements, length, breadth and height with 268 unit of measure; or a derating curve as an appropriate series of data element pairs. 269 This part of IEC 61987 conforms to ISO 15926 Part 1 and Part 2 with respect to the data model

and associated reference data library (Part 4), for example, as used for the limited classification

270

- 9 -IEC CDV 61987-1 ED2 2023 CDV ©IEC:2023

- structure. At the same time, it is also aligned to STEP: Standard for the Exchange of Product Model Data. The data model and definitions of ISO 10303 Part 221 uses the ISO 15926 Part 4
- TS Reference Data Library as "library". The current standard can reproduce the data fields as
- per this standard, including, for example, product structure data, dimensional data, electrical
- 275 connection data and product properties such as measuring range or power supply.
- 276 Since the publication of Edition 1 of this standard a great deal of work has been done in the
- 277 development of the IEC Common Data Dictionary for equipment for industrial-process
- automation. This, published as further parts of IEC 61987, covers not only measuring
- instruments with a variety of inputs and outputs, but also final control elements, infrastructure
- 280 devices and in future process analysers.
- 281 For this reason, the title has been adjusted and the scope has been revised to reflect the current
- 282 content of the whole IEC 61987 standard series.
- During the development of the IEC CCD a number of questions arose regarding the structure
- proposed in Part 1, in particular the assignment of any digital communication interface to the
- output. Although this is not strictly incorrect, it was thought that the properties of such an
- 286 interface could be better described separately. For this reason, a clause "Digital
- communication" has been added to Edition 2. In addition, the clause "Mechanical construction"
- 288 has been renamed "Mechanical and electrical construction" to reflect its true content.
- 289 "Ordering information" is not found as a separate block in the IEC CDD, as it is assumed that
- the properties there describe the type and particular instance of an already purchased device.
- 291 For an ordering process using IEC CDD properties, the necessary information is retrieved from
- the "Identification" which also includes the ordering information.
- 293 "Certificates and approvals" can be found both in the device list of properties
- 294 (0112/2///61987#ABC156) and as a device aspect within the "device documents supplied"
- 295 (0112/2///61987#ABH517). This is also the location of the information contained in
- 296 "Documentation".

301 302

- 297 In preparing Edition 2 of this standard all terms and definitions have been checked and where
- 298 necessary the references updated. Since the publication of Edition 1 in 2006 a number of
- 299 standards have been withdrawn. Where no suitable alternative source has been found, a note
- 300 to this effect has been added, but the original term and definition have been left unchanged.

- 10 -IEC CDV 61987-1 ED2 2023 CDV

©IEC:2023

303 304 305 306 307 308 309	INDUSTRIAL-PROCESS MEASUREMENT AND CONTROL: DATA STRUCTURES AND ELEMENTS IN PROCESS EQUIPMENT CATALOGUES – Part 1: Generic structures for measuring devices
310	1 Scope
311 312 313 314 315	IEC 61987-1 defines a generic structure in which product features of industrial process measurement devices shall be arranged, in order to facilitate the understanding of product descriptions when they are transferred from one party to another. It applies to the production of catalogues supplied by the manufacturer of such devices and helps the user to formulate his requirements.
316 317	IEC 61987-1 shall also serve as a reference document for all future standards which are concerned with process measuring equipment.
318 319 320	In addition, IEC 61987-1 also provides a basic structure for the production of further standards listing the properties of process control equipment, for example, for actuators and infrastructure devices.
321	2 Normative references iTeh Standards
322 323 324	The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.
325 326	IEC 60050-151:2001, International Electrotechnical Vocabulary – Part 151: Electrical and magnetic devices
327 328	IEC 60050-311:2001, International Electrotechnical Vocabulary – Part 311: General terms 987-1-2024 relating to measurements
329 330	IEC 60050-351:19982013: International Electrotechnical Vocabulary – Part 351: Automatic control
331 332	IEC 60050-426: 2020: International Electrotechnical Vocabulary – Part 426: Equipment for explosive atmospheres
333	IEC 60068 (all parts), Environmental testing
334	IEC 60529:1989+A1:1999+A2:2013, Degrees of protection provided by enclosures (IP Code)
335	IEC 60559:19892020, Floating-point arithmetic
336 337	IEC 60654-1:1993: Industrial-process measurement and control equipment - Operating conditions - Part 1: Climatic conditions
338 339	IEC 60721-3 (all parts): Classification of environmental conditions - Classification of groups of environmental parameters and their severities
340	IEC 60751: 2022, Industrial platinum resistance thermometer sensors

- 11 -IEC CDV 61987-1 ED2 2023 CDV

©	IF.	\mathbf{C}	.つ	N	2	ገ
0	_	v		v	_	J

- 341 IEC 61000-1-1:1992, Electromagnetic compatibility (EMC) Part 1: General Section 1:
- 342 Application and interpretation of fundamental definitions and terms
- 343 IEC 61069: (all parts), Industrial-process measurement and control Evaluation of system
- 344 properties for the purpose of system assessment
- 345 IEC 61082-1:2014, Preparation of documents used in electrotechnology Part 1 Rules
- 346 IEC 61298 (all parts), Process measurement and control devices General methods and
- 347 procedures for evaluating performance
- 348 IEC 61326 (all parts): Electrical equipment for measurement, control and laboratory use EMC
- 349 requirements
- 350 IEC 61508 (all parts): Functional safety of electrical/electronic/programmable electronic safety
- 351 related systems
- 352 IEC 61987-11: Data structures and elements in process equipment catalogues List of
- 353 properties (LOPs) of measuring equipment for electronic data exchange Generic structures
- 354 IEC 62828 (all parts): Reference conditions and procedures for testing industrial and process
- 355 measurement transmitters
- 356 IEC 82045-1:2001, Document management Part 1: Principles and methods
- 357 International Vocabulary of Metrology (VIM), 3rd Edition: Basic and general concepts and
- 358 associated terms (VIM) ISO/IEC Guideline 99/2007
- 359 ISO 3511-1:1977, Process measurement control functions and instrumentation Symbolic
- 360 representation Part 1: Basic requirements

361 3 Terms and definitions oSIST prEN IEC 61987-1:2024

- For the purposes of this document, the following terms and definitions apply.
- 363 ISO and IEC maintain terminological databases for use in standardization at the following
- 364 addresses:
- IEC Electropedia: available at http://www.electropedia.org
- ISO Online browsing platform: available at http://www.iso.org/obp
- 367 **3.1**
- 368 accuracy (of a measuring instrument)
- 369 inaccuracy
- 370 quality which characterizes the ability of a measuring instrument to provide an indicated value
- 371 close to a true value of the measured value under reference conditions
- NOTE 1 to entry: This term is used in the "true value" approach.
- NOTE 2 to entry: Accuracy is all the better when the indicated value is closer to the corresponding true value.
- 374 NOTE 3 to entry: Inaccuracy as defined in IEC 61298-2 includes the errors of non-linearity, non-repeatability and
- 375 hysteresis.
- NOTE 4 to entry: Accuracy can be expressed as percentage of reading, span or full range etc. or as an absolute
- 377 value

61987-1 ED2 - 12 -IEC CDV 2023 CDV

©IEC:2023

- [SOURCE IEC 60050 311-06-08 modified, measured value instead of measurand, under 378
- 379 reference conditions added, Notes 3 and 4 added]
- 380 3.2
- 381 accuracy class
- category of instruments or components thereof, all of which are intended to comply with a set 382
- of specifications regarding uncertainty 383
- [SOURCE IEC 60050 311-06-09 modified, "or components" added] 384
- 385
- 386 ambient condition,
- 387 environmental condition
- 388 characteristics of the environment which may affect the performance of the device or system
- 389 NOTE Examples of ambient conditions are pressure, temperature, humidity, vibration, radiation.
- 390 [SOURCE: IEC 60050, 151-16-03]
- 391
- 392 ambient temperature
- 393 temperature measured at a representative point within the local environment, including adjacent
- 394 heat generating equipment, in which the measurement and control equipment will normally
- 395 operate, be stored or transported.
- 396 See 3.3

- 397 3.5
- ambient temperature limits 398
- 399 extreme values of ambient temperature to which a device may be subjected without permanent
- 400 impairment of operating characteristics.
- 401 NOTE The performance characteristics may be exceeded in the range between the limits of normal operation and
- 402 the operating temperature limits.
- 403 See 3.21, 3.22
- 404 3.6
- 405 ambient temperature range
- 406 range of ambient temperatures within which a device is designed to operate within specified
- 407 accuracy limits.
- 408 See 3.32, 3.34
- 409 3.7
- 410 analog signal
- signal each information parameter of which directly represents the respective variable quantity 411
- 412 413 NOTE: An analog signal may be a continuous-value signal or a discrete-value signal as well as a continuous-time
- or a discrete-time signal. Examples may be the pressure in a pneumatic final controlling element with continuous-414 value and continuous-time information parameter (value of the pressure) as well as a position-modulated pulse signal
- 415 as an output signal of a computer based controller.
- 416 [SOURCE: IEC 60050, 351-41-24]
- 417